

# N-Channel 100 V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	$R_{DS(on)}\left(\Omega\right)$	I <sub>D</sub> (A) <sup>a, e</sup>	Q <sub>g</sub> (Typ.)			
100	0.095 at V <sub>GS</sub> = 10 V	3.2	4.2 nC			
100	0.105 at V <sub>GS</sub> = 4.5 V	3.0	4.2110			

# TSOP-6 Top View

#### **FEATURES**

Halogen-free According to IEC 61249-2-21 Definition



- Low On-Resistance
- 100 % R<sub>g</sub> Tested
- Compliant to RoHS Directive 2002/95/EC



COMPLIANT

#### **APPLICATIONS**

• DC/DC Converters, High Speed Switching

ABSOLUTE MAXIMUM RATIN	<b>GS</b> (T <sub>A</sub> = 25 °C	, unless othe	rwise noted)	
Parameter		Symbol	Limit	Unit
Drain-Source Voltage		$V_{DS}$	100	V
Gate-Source Voltage		$V_{GS}$	± 20	V
	T <sub>C</sub> = 25 °C		3.2 <sup>e</sup>	
Continuous Drain Current (T <sub>.I</sub> = 150 °C)	T <sub>C</sub> = 70 °C	] [	2.8 <sup>e</sup>	
Continuous Diam Current (1) = 150 °C)	T <sub>A</sub> = 25 °C		3.0 <sup>b, c</sup>	
	T <sub>A</sub> = 70 °C		2.4 <sup>b, c</sup>	A
Pulsed Drain Current (t = 300 μs)	Pulsed Drain Current (t = 300 μs)		25	
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	1.	2.1	
Continuous Source-Diain Diode Current	T <sub>A</sub> = 25 °C	l <sub>S</sub>	1.1 <sup>b, c</sup>	
	T <sub>C</sub> = 25 °C		2.5	
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	P <sub>D</sub>	1.6	W
Maximum Fower Dissipation	T <sub>A</sub> = 25 °C		1.3 <sup>b, c</sup>	VV
	T <sub>A</sub> = 70 °C	1	0.8 <sup>b, c</sup>	
Operating Junction and Storage Temperature	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	
Soldering Recommendations (Peak Tempera		260		

THERMAL RESISTANCE RATINGS							
Parameter	Symbol	Typical	Maximum	Unit			
Maximum Junction-to-Ambient <sup>b, d</sup>	t ≤ 5 s	R <sub>thJA</sub>	75	100	°C/W		
Maximum Junction-to-Foot (Drain)	Steady State	R <sub>thJF</sub>	40	50	C/ VV		

- a. Based on  $T_C = 25$  °C.
- b. Surface mounted on 1" x 1" FR4 board.
- d. Maximum under steady state conditions is 166 °C/W.
- e. Package limited.

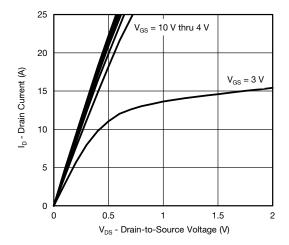


Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static					•	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	100			V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = 250 μA		30		mV/°C
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_{J}$	I <sub>D</sub> = 250 μA		- 4.8		
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}$ , $I_{D} = 250 \mu A$	1.0		2.5	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
7 0		V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V			1	μΑ
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 70 °C			10	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \le 5 \text{ V}, V_{GS} = 10 \text{ V}$	20			Α
D : 0		$V_{GS} = 10 \text{ V}, I_D = 3.0 \text{ A}$		0.095		Ω
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, I_D = 2 \text{ A}$		0.105		
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	$V_{DS} = 50V$ , $I_{D} = 3.0 A$		24		S
Dynamic <sup>b</sup>				•	•	
Input Capacitance	C <sub>iss</sub>			424		pF
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		100		
Reverse Transfer Capacitance	C <sub>rss</sub>			42		
Total Oata Ohamus	Qg	$V_{DS} = 50 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 3.0 \text{ A}$		8.2	13	nC
Total Gate Charge				4.2	7	
Gate-Source Charge	$Q_{gs}$	$V_{DS} = 50 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 3.0 \text{ A}$		1.4		
Gate-Drain Charge	$Q_{gd}$			1.4		
Gate Resistance	$R_{g}$	f = 1 MHz	2.5	12.6	25.2	Ω
Turn-On Delay Time	t <sub>d(on)</sub>			6	12	
Rise Time	t <sub>r</sub>	$V_{DD}$ = 50 V, $R_L$ = 3.4 $\Omega$		20	30	ns
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \approx 4.4 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		14	21	
Fall Time	t <sub>f</sub>			10	20	
Turn-On Delay Time	t <sub>d(on)</sub>			3	6	
Rise Time	t <sub>r</sub>	$V_{DD}$ = 50 V, $R_L$ = 3.4 $\Omega$		11	20	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \approx 2.4 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		20	30	
Fall Time	t <sub>f</sub>			7	14	
<b>Drain-Source Body Diode Characteristic</b>	s		<u>l</u>		l	
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C		2.1		٨
Pulse Diode Forward Current	I <sub>SM</sub>			25		A
Body Diode Voltage	$V_{SD}$	$I_S = 2.4 \text{ A}, V_{GS} = 0 \text{ V}$		0.82	1.2	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>			13	20	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	L = 2.4.4. dl/dt = 400.4/::2. T = 05.90		6	12	nC
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = 2.4 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		8		
Reverse Recovery Rise Time t <sub>b</sub>				5	1	ns

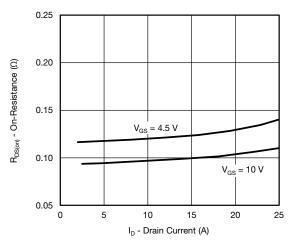
- a. Pulse test; pulse width ≤ 300 μs, duty cycle ≤ 2 %.
  b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

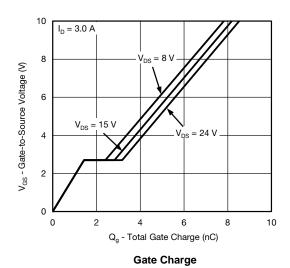




#### **Output Characteristics**



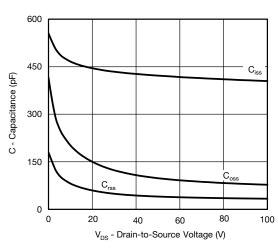
On-Resistance vs. Drain Current and Gate Voltage



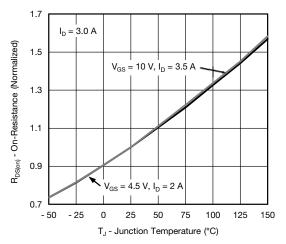
5
4
3
T<sub>C</sub> = 25 °C
T<sub>C</sub> = -55 °C

0
0
0.5
1
1.5
2
2.5
3
V<sub>GS</sub> - Gate-to-Source Voltage (V)

**Transfer Characteristics** 

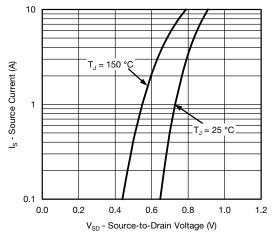


Capacitance

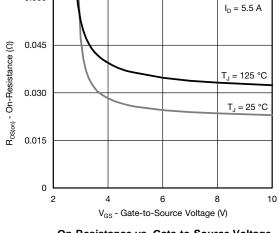


On-Resistance vs. Junction Temperature



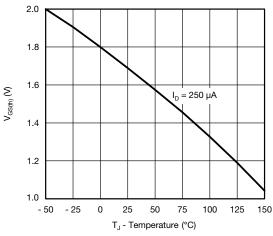


Source-Drain Diode Forward Voltage

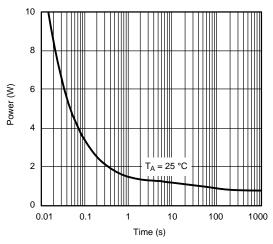


0.060

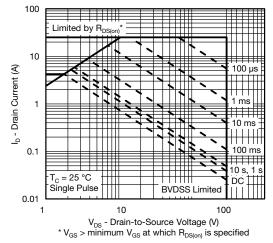
On-Resistance vs. Gate-to-Source Voltage



**Threshold Voltage** 

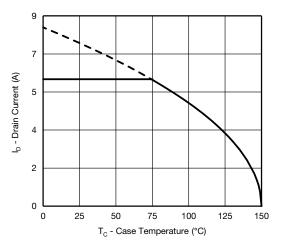


Single Pulse Power (Junction-to-Ambient)

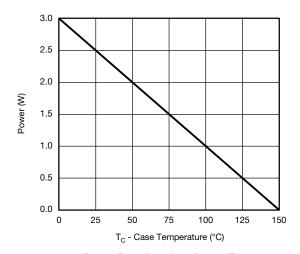


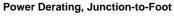
Safe Operating Area, Junction-to-Ambient

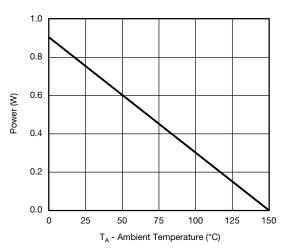




#### **Current Derating\***



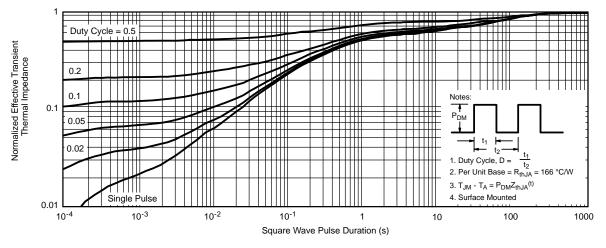




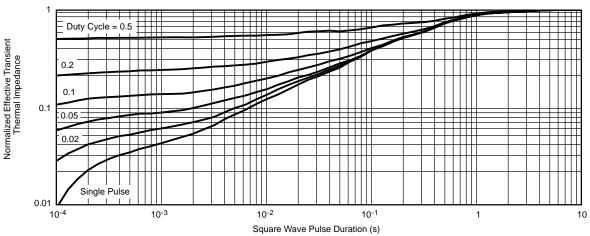
**Power Derating, Junction-to-Ambient** 

<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max.)}$  = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient

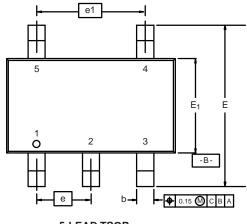


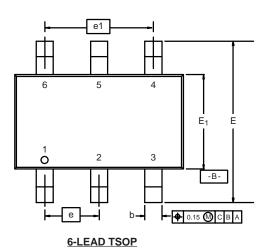
Normalized Thermal Transient Impedance, Junction-to-Foot



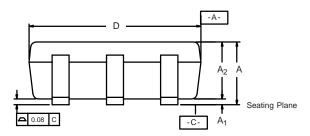
TSOP: 5/6-LEAD

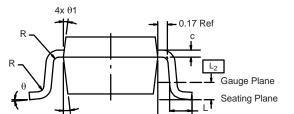
**JEDEC Part Number: MO-193C** 





**5-LEAD TSOP** 





 $(L_1)$ 

4x θ1

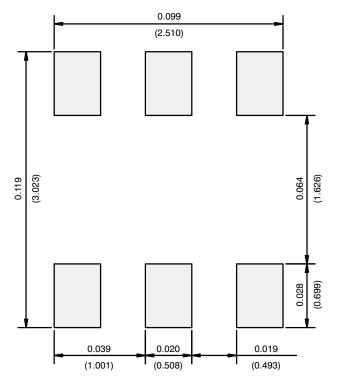
	MIL	LIMETER	RS	INCHES			
Dim	Min	Nom	Max	Min	Nom	Max	
Α	0.91	-	1.10	0.036	-	0.043	
A <sub>1</sub>	0.01	-	0.10	0.0004	-	0.004	
A <sub>2</sub>	0.90	-	1.00	0.035	0.038	0.039	
b	0.30	0.32	0.45	0.012	0.013	0.018	
С	0.10	0.15	0.20	0.004	0.006	0.008	
D	2.95	3.05	3.10	0.116	0.120	0.122	
E	2.70	2.85	2.98	0.106	0.112	0.117	
E <sub>1</sub>	1.55	1.65	1.70	0.061	0.065	0.067	
е		0.95 BSC		0.0374 BSC			
e <sub>1</sub>	1.80	1.90	2.00	0.071	0.075	0.079	
L	0.32	-	0.50	0.012	-	0.020	
L <sub>1</sub>	0.60 Ref			0.024 Ref			
L <sub>2</sub>	0.25 BSC			0.010 BSC			
R	0.10	-	-	0.004	-	1	
θ	0°	4°	8°	0°	4°	8°	
$\theta_1$	7° Nom			7° Nom			
ECN: C-06593-Rev. I, 18-Dec-06							

DWG: 5540

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#### **RECOMMENDED MINIMUM PADS FOR TSOP-6**



Recommended Minimum Pads Dimensions in Inches/(mm)



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